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2015年12月

FDPF190N15A

N 沟道 PowerTrench[®] MOSFET 150 V,27.4 A,19 mΩ

特性

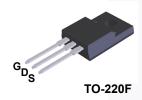
- $R_{DS(on)} = 14.7 \text{ m}\Omega \text{ (Typ.)}@V_{GS} = 10 \text{ V, } I_D = 27.4 \text{ A}$
- 低栅极电荷, Q_G = 31 nC (典型值)
- 低 C_{rss} (典型值 56 pF)
- 快速开关速度
- · 改善的 dv/dt 处理能力
- 符合 RoHS 标准

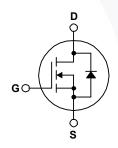
说明

此 N 沟道 MOSFET 采用飞兆半导体先进的 PowerTrench® 工艺 生产,这一先进工艺是专为最大限度地降低通态电阻并保持卓越 开关性能而定制的。

应用

- 消费电子设备
- LED 电视
- 用于 ATX/Sever/Telecom PSU 的同步整流
- 不间断电源
- 微型太阳能逆变器





绝对最大额定值 T_C = 25℃ 除非另有说明。

符号		参数		FDPF190N15A	单位
V _{DSS}	漏极一源极电压			150	V
V_{GSS}	100 to 10	- DC	/	±20	V
	栅极一源极电压	- AC	(f > 1 Hz)	±30	V
	72.17.4×	一连续 (T _C = 25°C)		27.4	Α
ID	漏极电流	一连续 (T _C = 100°C)		17.4	A
I _{DM}	漏极电流	一脉冲	(注1)	110	Α
E _{AS}	单脉冲雪崩能量		(注2)	261	mJ
dv/dt	二极管恢复 dv/dt 峰值		(注3)	6.0	V/ns
П	-1.+-	(T _C = 25°C)		33	W
P_{D}	功耗 一超过 25°C 时降额			0.26	W/°C
T _J , T _{STG}	工作和存储温度范围			-55 至 +150	°C
TL	用于焊接的最大引脚温度,	距离外壳 1/8",持续 5 秒		300	°C

热性能

符号	参数	FDPF190N15A	单位
$R_{\theta JC}$	结至外壳热阻最大值	3.3	°C/W
$R_{\theta JA}$	结至环境热阻最大值	62.5	* 6/70

封装标识与定购信息

器件编号	顶标	封装	包装方法	卷尺寸	带宽	数量
FDPF190N15A	FDPF190N15A	TO-220F	塑料管	不适用	不适用	50 单元

电气特性 T_C = 25℃ 除非另有说明。

符号	参数	测试条件	最小值	典型值	最大值	单位
关断特性						
BV_{DSS}	漏极一源极击穿电压	$I_D = 250 \mu A, V_{GS} = 0 V$	150	-	-	V
ΔBV _{DSS} / ΔT _J	击穿电压温度系数	I _D = 250 μA,参考 25°C	-	0.14	-	V/°C
1	泰州林中广海林中 本	$V_{DS} = 120 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μА
IDSS	零栅极电压漏极电流	$V_{DS} = 120 \text{ V}, T_{C} = 150^{\circ}\text{C}$	-	-	500	μΑ
I_{GSS}	栅极 - 体漏电流	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA

导通特性

V _{GS(th)}	栅极阈值电压	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	漏极至源极静态导通电阻	V _{GS} = 10 V, I _D = 27.4 A	-	14.7	19.0	mΩ
g _{FS}	正向跨导	V _{DS} = 10 V, I _D = 27.4 A	-	64	-	S

动态特性

C _{iss}	输入电容	V 05 V V 0 V	-	2020	2685	pF
C _{oss}	输出电容	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	-	700	930	pF
C _{rss}	反向传输电容	1 = 1 WH 12	-\	56	85	pF
C _{oss(er)}	能源相关输出电容	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}$	- \	252	-	pF
Q _{g(tot)}	10V 的栅极电荷总量	V _{DS} = 120 V, I _D = 27.4 A,	- \	30	39	nC
Q_{gs}	栅极一源极栅极电荷	V _{GS} = 10 V	-	8.8	-	nC
Q_{gd}	栅极一漏极"密勒"电荷	(说明 4	-	7.3	-	nC
ESR	等效串联电阻 (G-S)	f = 1 MHz	-	1.5	-	Ω

开关特性

		,				
t _{d(on)}	导通延迟时间		-	18	46	ns
t _r		$V_{DD} = 75 \text{ V}, I_D = 27.4 \text{ A},$	-	16	42	ns
t _{d(off)}	关断延迟时间	$V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$	- /	32	74	ns
t _f	关断下降时间	(说明 4)	-	8	26	ns

漏极一源极二极管特性

Is	漏极一源极二极管最大正向连续电流	漏极一源极二极管最大正向连续电流		-	27.4	Α
I _{SM}	漏极一源极二极管最大正向脉冲电流		-	-	110	Α
V_{SD}	漏极一源极二极管正向电压	$V_{GS} = 0 \text{ V}, I_{SD} = 27.4 \text{ A}$	-	-	1.3	V
t _{rr}	反向恢复时间	$V_{GS} = 0 \text{ V}, I_{SD} = 27.4 \text{ A},$	-	76	-	ns
Q_{rr}	反向恢复电荷	$dI_F/dt = 100 A/\mu s$, $V_{DD} = 120 V$	-	0.18	-	μС

- 1. 重复额定值:脉冲宽度受限于最大结温。

- 4. 本质上独立于工作温度的典型特性。

典型性能特征

图 1. 导通区域特性

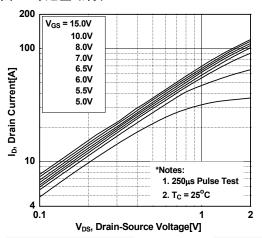


图 2. 传输特性

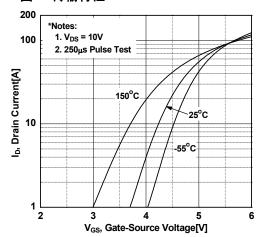


图 3. 导通电阻变化与漏极电流和栅极电压

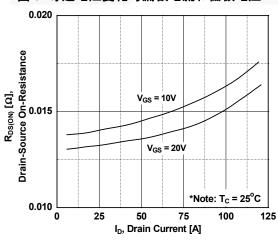


图 4. 体二极管正向电压变化与源电流和温度

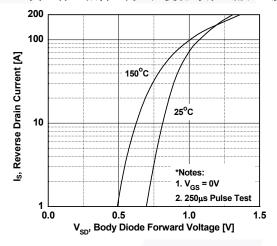


图 5. 电容特性

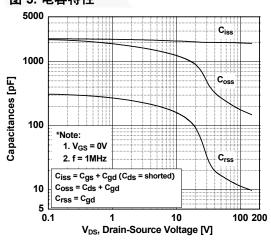
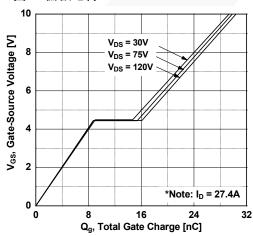


图 6. 栅极电荷



典型性能特征 (接上页)

图 7. 击穿电压变化与温度

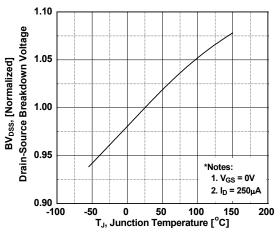


图 8. 导通电阻变化与温度

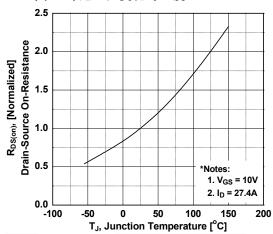


图 9. 最大安全工作区

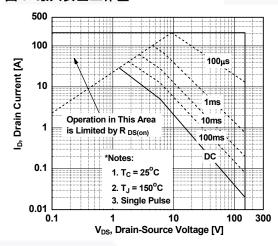


图 10. 最大漏极电流与壳体温度

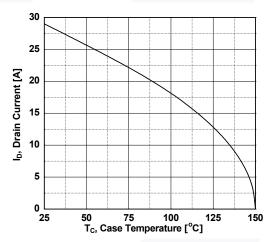
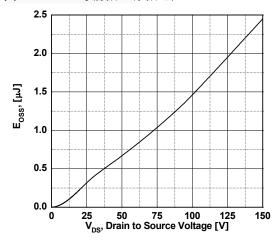
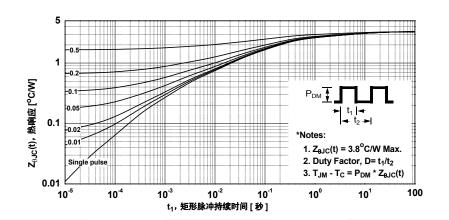


图 11. Eoss 与漏极一源极电压



典型性能特征 (接上页)

图 12. 瞬态热响应曲线



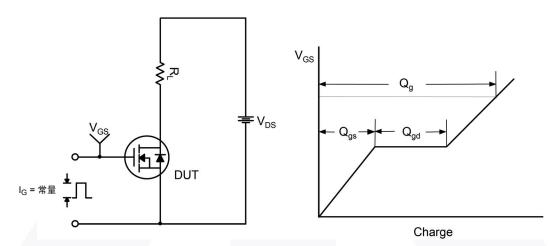


图 13. 栅极电荷测试电路与波形

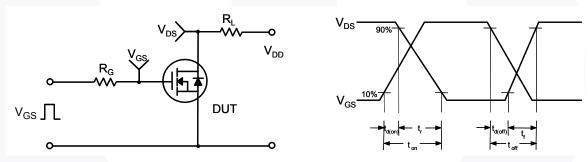


图 14. 阻性开关测试电路与波形

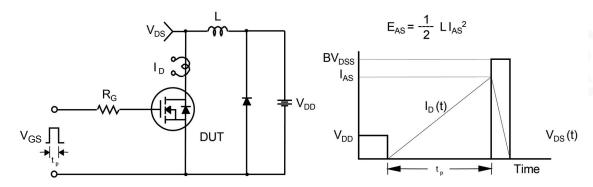


图 15. 非箝位感性开关测试电路与波形

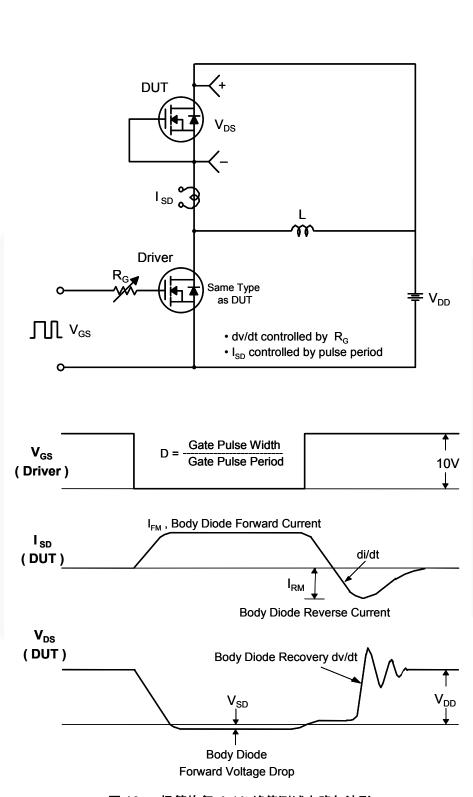
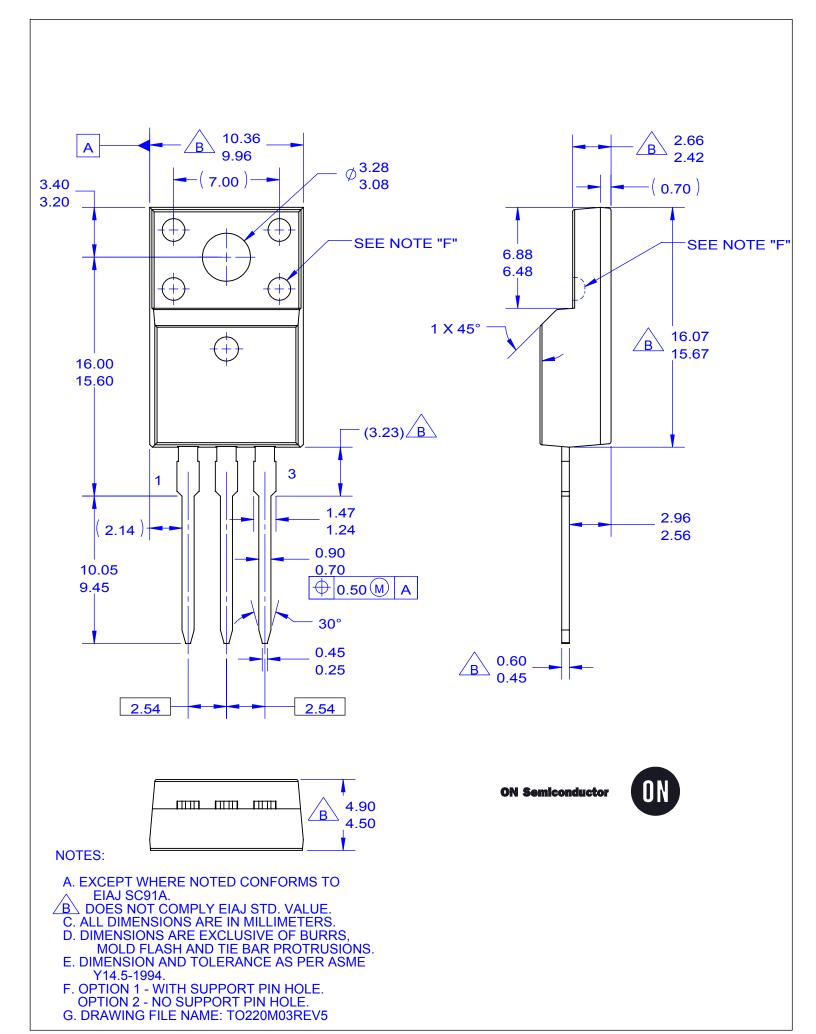


图 16. 二极管恢复 dv/dt 峰值测试电路与波形



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